## Notice of References Cited Application/Control No. 11/513,450 Examiner Paul Dinh Applicant(s)/Patent Under Reexamination VAN ANTWERPEN ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0132316	06-2005	Suaris et al.	716/011
*	В	US-2004/0225970	11-2004	Oktem, Levent	716/001
*	С	US-7,162,704	01-2007	Oktem, Levent	716/6
*	D	US-5,822,217	10-1998	Shenoy, Narendra V.	716/6
*	Е	US-5,644,499	07-1997	Ishii, Alexander T.	716/6
	F	US-			
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	>						
	w						
	х						

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